

Notice of References Cited		Application/Control No. 10/553,828	Applicant(s)/Patent Under Reexamination HASEBE ET AL.	
		Examiner Eric Golightly	Art Unit 1792	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,352,591	03-2002	Yieh et al.	118/697
	B	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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NON-PATENT DOCUMENTS

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